

MOS FIELD EFFECT TRANSISTOR μ PA1709

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

This product is N-Channel MOS Field Effect Transistor designed for DC/DC converters and power management switch.

FEATURES

· Low on-resistance

 $R_{DS(on)1} = 9.3~m\Omega$ (TYP.) (Vgs = 10 V, Ip = 4.5 A)

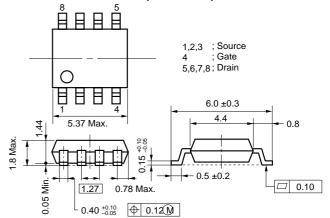
 $R_{DS(on)2} = 13.8 \text{ m}\Omega \text{ (TYP.) (Vgs} = 4.5 \text{ V, Ip} = 4.5 \text{ A)}$

- Low Ciss : Ciss = 1850 pF (TYP.)
- Built-in G-S protection diode
- Small and surface mount package (Power SOP8)

ORDERING INFORMATION

PART NUMBER	PACKAGE
μ PA1709G	Power SOP8

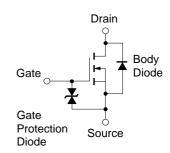
PACKAGE DRAWING (Unit: mm)



ABSOLUTE MAXIMUM RATINGS (TA = 25°C, All terminals are connected.)

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Drain to Source Voltage (Vss = 0 V)	VDSS	40	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±25	V
Drain Current (DC)	ID(DC)	±9.0	Α
Drain Current (pulse) Note1	I _{D(pulse)}	±36	Α
Total Power Dissipation ($T_A = 25^{\circ}C$) Note2	Рт	2.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	T _{stg}	-55 to + 150	°C

EQUIVARENT CIRCUIT



- **Notes 1.** PW \leq 10 μ s, Duty Cycle \leq 1 %
 - 2. Mounted on ceramic substrate of 1200 mm² x 0.7 mm

Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

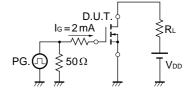
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ELECTRICAL CHARACTERISTICS (TA = 25 °C, All terminals are connected.)

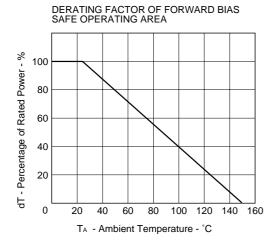
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, Ip = 4.5 A		9.3	12.5	mΩ
	RDS(on)2	Vgs = 4.5 V, ID = 4.5 A		13.8	20.0	mΩ
Gate to Source Cut-off Voltage	V _{GS(off)}	V _{DS} = 10 V, I _D = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	yfs	V _{DS} = 10 V, I _D = 4.5 A	8.0	14		S
Drain Leakage Current	IDSS	Vps = 40 V, Vgs = 0 V			10	μΑ
Gate to Source Leakage Current	lgss	Vgs = ±25 V, Vps = 0 V			±10	μΑ
Input Capacitance	Ciss	V _{DS} = 10 V		1850		pF
Output Capacitance	Coss	V _G S = 0 V		790		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		330		pF
Turn-on Delay Time	td(on)	ID = 4.5 A		27		ns
Rise Time	tr	$V_{GS(on)} = 10 \text{ V}$		95		ns
Turn-off Delay Time	t d(off)	V _{DD} = 20 V		110		ns
Fall Time	t _f	$R_G = 10 \Omega$		70		ns
Total Gate Charge	Q _G	ID = 9.0 A		43.0		nC
Gate to Source Charge	Qgs	V _{DD} = 32 V		6.0		nC
Gate to Drain Charge	Q _{GD}	V _G S = 10 V		14.0		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 9.0 A, VGS = 0 V		0.78		V
Reverse Recovery Time	trr	IF = 9.0 A, VGS = 0 V		47		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ μ s		44		nC

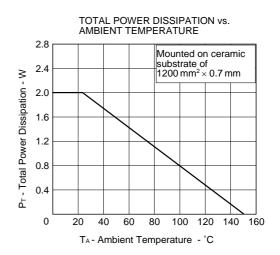
TEST CIRCUIT 1 SWITCHING TIME

TEST CIRCUIT 2 GATE CHARGE

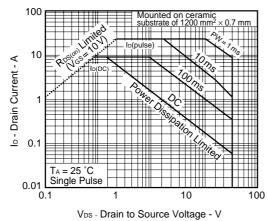


TYPICAL CHARACTERISTICS (TA = 25 °C)

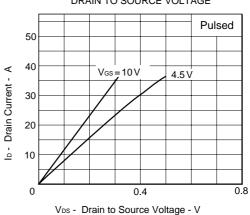




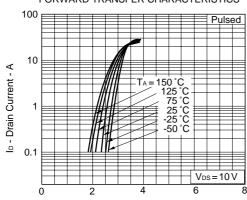
★ FORWARD BIAS SAFE OPERATING AREA







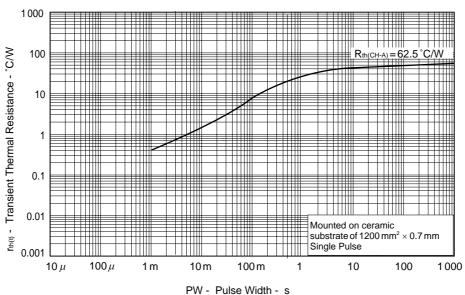
FORWARD TRANSFER CHARACTERISTICS



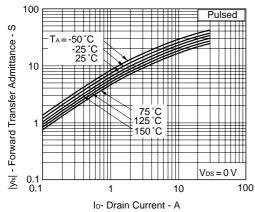
V_{GS} - Gate to Source Voltage - V

VBS Brain to Gourge Voltage V

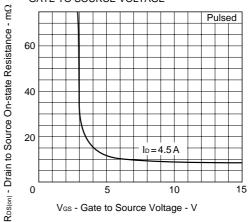
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



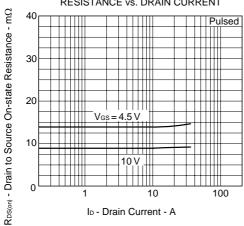
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



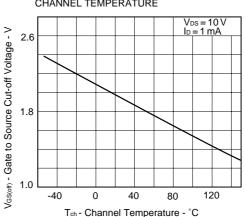
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

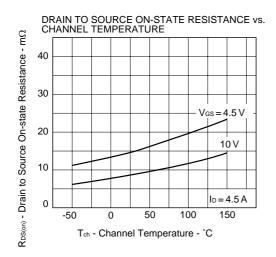


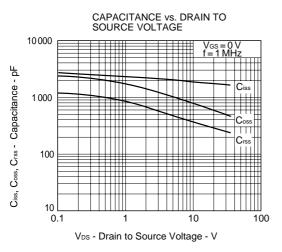
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

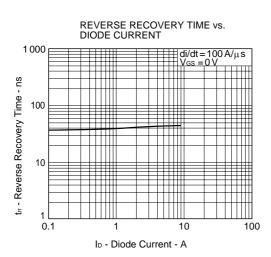


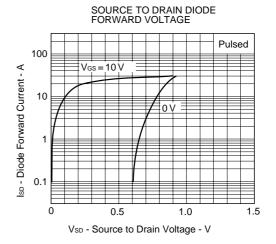
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE

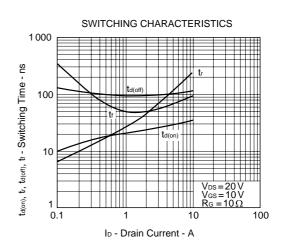


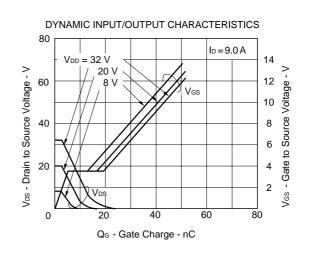












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